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ISO7821, ISO7821F

SLLSEM2D - NOVEMBER 2014-REVISED JULY 2015

ISO7821 ISO7821F High-Performance, 8000 VPK Reinforced Dual Channel Digital Isolator

Technical

Documents

1 Features

- Signaling Rate: Up to 100 Mbps
- Wide Supply Range: 2.25 V to 5.5 V
- 2.25 V to 5.5 V Level Translation
- Wide Temperature Range: -55°C to 125°C
- Low Power Consumption, Typical 1.8 mA per Channel at 1 Mbps
- Low Propagation Delay: 11 ns Typical (5 V Supplies)
- Industry leading CMTI: ±100 kV/µs
- Robust Electromagnetic Compatibility (EMC)
- System-Level ESD, EFT, and Surge Immunity
- Low Emissions
- Isolation Barrier Life: > 25 Years
- Wide Body (DW) SOIC-16 Package
- Safety and Regulatory Approvals:
 - 8000 V_{PK} V_{IOTM} and 2121 V_{PK} V_{IORM} Reinforced Isolation per DIN V VDE V 0884-10 (VDE V 0884-10):2006-12
 - 5.7 kV_{RMS} Isolation for 1 minute per UL 1577
 - CSA Component Acceptance Notice 5A, IEC 60950-1, IEC 60601-1 and IEC 61010-1 End **Equipment Standards**
 - CQC Certification per GB4943.1-2011

2 Applications

- Industrial Automation
- Motor Control
- Power Supplies
- Solar Inverters
- Medical Equipment
- Hybrid Electric Vehicles

3 Description

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The ISO7821 is a high-performance, dual-channel digital isolator with 8000 VPK isolation voltage. This device reinforced isolation certifications has according to VDE, CSA, and CQC. The isolator provides high electromagnetic immunity and low emissions at low power consumption, while isolating CMOS or LVCMOS digital I/O's. Each isolation channel has a logic input and output buffer separated by silicon dioxide (SiO₂) insulation barrier. ISO7821 has one forward and one reverse-direction channel. If the input power or signal loss, default output is 'high' for the ISO7821 and 'low' for the ISO7821F device. Used in conjunction with isolated power supplies, this device prevents noise currents on a data bus or other circuits from entering the local ground and interfering with or damaging sensitive circuitry. Through innovative chip design and layout techniques, electromagnetic compatibility of ISO7821 has been significantly enhanced to ease system-level ESD, EFT, Surge and Emissions compliance. ISO7821 is available in 16-pin SOIC wide-body (DW) package.

Support &

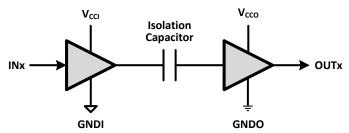
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Device Information⁽¹⁾

PART NUMBER	PACKAGE	BODY SIZE (NOM)
ISO7821/ ISO7821F	SOIC, DW (16)	10.30 mm x 7.50 mm

(1) For all available packages, see the orderable addendum at the end of the datasheet.



Simplified Schematic

- (1) V_{CCI} and GNDI are supply and ground connections respectively for the input channels.
- (2) V_{CCO} and GNDO are supply and ground connections respectively for the output channels.



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4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision C (May 2015) to Revision D

•	Added device ISO7821F to the datasheet	1
•	Changed the <i>Description</i> to include: "default output is 'high' for the ISO7821 device and 'low' for the ISO7821F device.	1
•	Changed the Simplified Schematic	1
•	Changed the Supply current TYP and MAX values in the <i>Electrical Characteristics, 5 V</i>	8
•	Changed the Supply current TYP and MAX values in the <i>Electrical Characteristics, 3.3 V</i>	9
•	Changed the Supply current TYP and MAX values in the <i>Electrical Characteristics</i> , 2.5 V	10
•	Changed t _{PLH} and t _{PHL} From: 5.5 V to 5 V in Figure 6	. 12
•	Changed Figure 8	. 13
•	Changed the Functional Block Diagram	. 14
•	Changed title From: IEC Insulation and Safety-Related Specifications for DW-16 Package To: Package Insulation and Safety-Related Specifications	. 15
•	Changed Figure 12 , Added Figure 13	

Changes from Revision B (April 2015) to Revision C

•	Changed From: V_{CC1} and V_{CC2} To: V_{CC1} and V_{CCO} , GND1 and GND2 To: GNDI and GNDO and added Notes 1 and 2 in the <i>Simplified Schematic</i>	1
•	Changed the MAX value of CMTI in <i>Electrical Characteristics, 5 V</i> table From: 50 To: 70 kV/µs	8
•	Changed the Supply current MAX values in the <i>Electrical Characteristics</i> , 5 V	8
•	Changed the MAX value of CMTI in <i>Electrical Characteristics, 3.3 V</i> table From: 50 To: 70 kV/µs	9
•	Changed the Supply current MAX values in the <i>Electrical Characteristics</i> , 3.3 V	9
•	Changed the MAX value of CMTI in <i>Electrical Characteristics, 2.5 V</i> table From: 50 To: 70 kV/µs	0
•	Changed the Supply current MAX values in the <i>Electrical Characteristics</i> , 2.5 V	0

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•	Added sentence "If the EN pin is available and low then the output goes to high impedance." to the <i>Overview</i> section	14
•	Changed the Functional Block Diagram to include the EN pin on the Receiver side	14
•	Changed the Installation classification of the IEC 60664-1 Ratings Table to include DW package information	16
•	Changed "ISO782W functional modes" To: "ISO7821DW functional modes" in Device Functional Modes	19
•	Changed Table 1 title From: "Functional Table" To: "ISO7821DW Function Table"	19
•	Added the Device I/O Schematics section	19
•	Changed device number ISO7821 To: ISO7821DW in Figure 16	21

Changes from Revision A (December 2014) to Revision B

Page

•	Changed the document title From: "Channel Digital Isolator" To: "Channel 1/1 Digital Isolator"	. 1
•	Added Features: 2.25 V to 5.5 V Level Translation	
•	Changed the Safety and Regulatory Approvals list of Features	. 1
•	Changed text in the <i>Description</i> From: "This device is being reviewed for reinforced isolation certification by VDE and CSA. To: "This device has reinforced isolation certifications according to VDE, CSA, and CQC."	. 1
•	Added Note (3) to the Absolute Maximum Ratings ⁽¹⁾ table	
•	Changed From: V _{CCX} To: V _{CCO} In I _{OH} and I _{OL} of the <i>Recommended Operating Conditions</i> table	. 6
•	Changed From: V_{CCX} To: V_{CCI} In V_{IH} and V_{IL} of the <i>Recommended Operating Conditions</i> table	
•	Changed Note (1) of the Recommended Operating Conditions table	
•	Added the Power Rating table	. 7
•	Changed From: V _{CCX} To: V _{CCO} In V _{OH} of the <i>Electrical Characteristics</i> , 5 V table	. 8
•	Changed From: V _{CCX} To: V _{CCO} In V _{I(HYS)} of the <i>Electrical Characteristics, 5 V</i> table	
•	Changed From: V _{CCX} To: V _{CCI} In I _{IH} of the <i>Electrical Characteristics, 5 V</i> table	. 8
•	Changed From: V _{CCX} To: V _{CCI} In CMTI of the <i>Electrical Characteristics, 5 V</i> table	. 8
•	Changed From: V _{CCX} To: V _{CCI} In Supply Current, DC Signal of the <i>Electrical Characteristics</i> , 5 V table	. 8
•	Changed Note (1) of the <i>Electrical Characteristics, 5 V</i> table	. 8
•	Changed From: V _{CCX} To: V _{CCO} In V _{OH} of the <i>Electrical Characteristics</i> , 3.3 V table	. 9
•	Changed From: V _{CCX} To: V _{CCO} In V _{I(HYS)} of the <i>Electrical Characteristics, 3.3 V</i> table	. 9
•	Changed From: V _{CCX} To: V _{CCI} In I _{IH} of the <i>Electrical Characteristics</i> , 3.3 V table	. 9
•	Changed From: V _{CCX} To: V _{CCI} In CMTI of the <i>Electrical Characteristics, 3.3 V</i> table	. 9
•	Changed From: V _{CCX} To: V _{CCI} In Supply Current, DC Signal of the <i>Electrical Characteristics</i> , 3.3 V table	. 9
•	Changed Note (1) of the <i>Electrical Characteristics</i> , 3.3 V table	. 9
•	Changed Note (1) of the <i>Electrical Characteristics</i> , 5 V table	. 9
•	Changed From: V_{CCX} To: V_{CCO} In V_{OH} of the <i>Electrical Characteristics</i> , 2.5 V table	10
•	Changed From: V_{CCX} To: V_{CCI} In I _{IH} of the <i>Electrical Characteristics</i> , 2.5 V table	10
•	Changed From: V _{CCX} To: V _{CCI} In Supply Current, DC Signal of the <i>Electrical Characteristics</i> , 2.5 V table	10
•	Changed Note (1) of the <i>Electrical Characteristics</i> , 5 V table	10
•	Changed Figure 7	
•	Changed From: V _{CC1} To: V _{CCI} in Figure 8	13
•	Changed Figure 9	
•	Changed the Test Condition of CTI of the table in Package Insulation and Safety-Related Specifications	15
•	Changed the MIN value of CTI From" > 600 V To: 600 V	15
•	Changed title From: DIN V VDE 0884-10 (VDE V 0884-10) and UL 1577 Insulation Characteristics To: Insulation	
	Characteristics	
•	Changed the table in Insulation Characteristics	
•	Changed columns VDE and CSA in the table in Regulatory Information	
•	Changed title From: IEC Safety Limiting Values To: Safety Limiting Values	18

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•	Changed the table in Safety Limiting Values, added I _S DW-16 package options	. 18
•	Changed Figure 12	. 18
•	Deleted INPUT-SIDE and OUTPUT-SIDE from columns 1 and 2 of Table 1	. 19
•	Changed Note (1) of Table 1	. 19
•	Changed the Application Information section	. 20
•	Changed the Typical Application section and Figure 15	. 20
•	Added text and Figure 16 to the Detailed Design Procedure section	. 21
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Changes from Original (November 2014) to Revision A

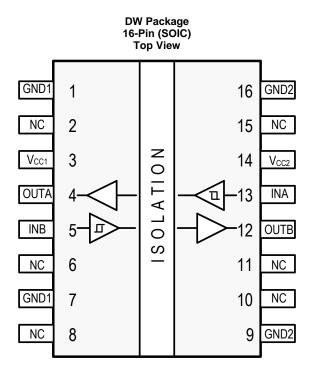
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•	Changed From: A produ	uct preview that included only page	1 and the pinout section 1	Fo: A complete data sheet	1
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5 Pin Configuration and Functions



Pin Functions

PIN			
NAME	NO.	I/O	DESCRIPTION
NAWE	DW		
GND1	1, 7	-	Ground connection for V _{CC1}
GND2	9, 16	-	Ground connection for V _{CC2}
INA	13	I	Input, channel A
INB	5	I	Input, channel B
NC	2, 6, 8, 10 ,11, 15	-	Not connected
OUTA	4	0	Output, channel A
OUTB	12	0	Output, channel B
V _{CC1}	3	-	Power supply, V _{CC1}
V _{CC2}	14	-	Power supply, V _{CC2}

Specifications 6

6.1 Absolute Maximum Ratings⁽¹⁾

		MIN	MAX	UNIT
Supply voltage ⁽²⁾	V _{CC1} , V _{CC2}	-0.5	6	V
Voltage	INx, OUTx	-0.5	$V_{CC} + 0.5^{(3)}$	V
Output Current	IO	-15	15	mA
Surge Immunity			12.8	kV
Maximum junction temperature	e, T _J		150	°C
Storage temperature, T _{stg}		-65	150	°C

(1) Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

All voltage values except differential I/O bus voltages are with respect to the local ground terminal (GND1 or GND2) and are peak (2)voltage values.

(3) Maximum voltage must not exceed 6 V.

6.2 ESD Ratings

			VALUE	UNIT
M	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins ⁽¹⁾	±6000	V
V _{ESD}	ESD Electrostatic discharge	Charged device model (CDM), per JEDEC specification JESD22-C101, all pins ⁽²⁾	±1500	V

JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process. (1)

JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process. (2)

6.3 Recommended Operating Conditions

			MIN	TYP	MAX	UNIT
V _{CC1} , V _{CC2}	Supply voltage		2.25		5.5	V
		$V_{CCO}^{(1)} = 5 V$	-4			
I _{OH}	High-level output current	V _{CCO} = 3.3 V	-2			mA
		$V_{CCO} = 2.5 V$	-1			
		$V_{CCO} = 5 V$			4	
I _{OL}	Low-level output current	$V_{CCO} = 3.3 V$			2	mA
		$V_{CCO} = 2.5 V$			1	
VIH	High-level input voltage		0.7 x V _{CCI} ⁽¹⁾		V _{CCI}	V
VIL	Low-level input voltage		0		$0.3 \times V_{CCI}$	V
DR	Signaling rate		0		100	Mbps
TJ	Junction temperature ⁽²⁾		-55		150	°C
T _A	Ambient temperature		-55	25	125	°C

(1)

 V_{CCI} = Input-side V_{CC} ; V_{CCO} = Output-side V_{CC} . To maintain the recommended operating conditions for T_J, see the *Thermal Information* table. (2)

6.4 Thermal Information

	THERMAL METRIC	DW (16 Pins)	UNIT
$R_{\theta JA}$	Junction-to-ambient thermal resistance	84.7	
R _{0JC(top)}	Junction-to-case(top) thermal resistance	47.3	
$R_{\theta JB}$	Junction-to-board thermal resistance	49.4	°C/W
Ψ _{JT}	Junction-to-top characterization parameter	19.1	°C/VV
ΨЈВ	Junction-to-board characterization parameter	48.8	
R _{0JC(bottom)}	Junction-to-case(bottom) thermal resistance	n/a	

6.5 Power Rating

			VALUE	UNIT
P_D	Maximum power dissipation by ISO7821	V _{CC1} = V _{CC2} = 5.5 V, T ₁ = 150°C,	100	
P _{D1}	Maximum power dissipation by side-1 of ISO7821	$C_L = 15 \text{ pF}$, input a 50 MHz 50% duty cycle	50	mW
P_{D2}	Maximum power dissipation by side-2 of ISO7821	square wave	50	

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6.6 Electrical Characteristics, 5 V

$V_{CC1} = V_{CC2} = 5 V \pm 10\%$ (over recommended)	d operating conditions unless otherwise noted)
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	PARAMETER	TES	ST CONDITIONS	MIN	TYP	MAX	UNIT
V _{OH}	High-level output voltage	I _{OH} = -4 mA; see Figure 7	I _{OH} = -4 mA; see Figure 7		$V_{CCO} - 0.2$		V
V _{OL}	Low-level output voltage	I _{OL} = 4 mA; see Figure 7			0.2	0.4	V
V _{I(HYS)}	Input threshold voltage hysteresis			0.1 x V _{CCO} ⁽¹⁾			V
I _{IH}	High-level input current	V _{IH} = V _{CCI} ⁽¹⁾ at INx				10	
IIL	Low-level input current	V _{IL} = 0 V at INx		-10			μA
CMTI	Common-mode transient immunity	$V_I = V_{CCI}$ or 0 V; see Figur	re 9	70	100		kV/µs
I _{CC1} , I _{CC2}		DC Signal	DC signal: $V_1 = 0 V$ (Devices with suffix F) , $V_1 = V_{CC1}^{(1)}$ (Devices without suffix F)		1.2	1.7	
I _{CC1} , I _{CC2}	Supply current	DC Signal	$\begin{array}{l} DC \mbox{ signal: } V_I = V_{CCI}^{(1)} \\ (Devices \mbox{ with suffix } F) \ , \ V_I = 0 \\ V(Devices \mbox{ without suffix } F) \end{array}$		2.4	3.4	mA
I _{CC1} , I _{CC2}		1 Mbps	AC Signal: All channels		1.8	2.6	
I _{CC1} , I _{CC2}		10 Mbps	switching with square wave clock input;		2.4	3.2	
I _{CC1} , I _{CC2}		100 Mbps	C _L = 15 pF		7.5	9.3	

(1) V_{CCI} = Input-side V_{CC} ; V_{CCO} = Output-side V_{CC} .



6.7 Electrical Characteristics, 3.3 V

 $V_{CC1} = V_{CC2} = 3.3 \text{ V} \pm 10\%$ (over recommended operating conditions unless otherwise noted)

	PARAMETER	TES	ST CONDITIONS	MIN	ТҮР	MAX	UNIT
V _{OH}	High-level output voltage	$I_{OH} = -2 \text{ mA}; \text{ see Figure 7}$		$V_{CCO}^{(1)} - 0.4$	V _{CCO} - 0.2		V
V _{OL}	Low-level output voltage	I _{OL} = 2 mA; see Figure 7			0.2	0.4	V
V _{I(HYS)}	Input threshold voltage hysteresis			0.1 x V _{CCO}			V
I _{IH}	High-level input current	$V_{IH} = V_{CCI}^{(1)}$ at INx				10	
IIL	Low-level input current	V _{IL} = 0 V at INx		-10			μA
CMTI	Common-mode transient immunity	$V_I = V_{CCI}$ or 0 V; see Figur	e 9	70	100		kV/µs
I _{CC1} , I _{CC2}		DC Signal	DC signal: $V_1 = 0 V$ (Devices with suffix F) , $V_1 = V_{CC1}^{(2)}$ (Devices without suffix F)		1.2	1.7	
I _{CC1} , I _{CC2}		DC Signal	DC signal: $V_I = V_{CCI}^{(2)}$ (Devices with suffix F) , $V_I = 0$ V(Devices without suffix F)		2.4	3.4	
I _{CC1} , I _{CC2}	Supply current	1 Mbps			1.8	2.6	mA
I _{CC1} , I _{CC2}		10 Mbps	AC Signal: All channels switching with square wave clock input; CL = 15 pF		2.2	3.0	
I _{CC1} , I _{CC2}		100 Mbps	······································		5.8	7.1	

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6.8 Electrical Characteristics, 2.5 V

 $V_{CC1} = V_{CC2} = 2.5 \text{ V} \pm 10\%$ (over recommended operating conditions unless otherwise noted)

	PARAMETER	TE	ST CONDITIONS	MIN	TYP	MAX	UNIT
V _{OH}	High-level output voltage	I _{OH} = -1 mA; see Figure 7		$V_{CCO}^{(1)} - 0.4$	$V_{CCO} - 0.2$		V
V _{OL}	Low-level output voltage	I _{OL} = 1 mA; see Figure 7			0.2	0.4	V
V _{I(HYS)}	Input threshold voltage hysteresis			0.1 x V _{CCO}			V
I _{IH}	High-level input current	$V_{IH} = V_{CCI}^{(1)}$ at INx				10	
I _{IL}	Low-level input current	V _{IL} = 0 V at INx		-10			μA
СМТІ	Common-mode transient immunity	$V_I = V_{CCI}$ or 0 V; see Figu	re 9	70	100		kV/µs
I _{CC1} , I _{CC2}		DC Signal	DC signal: $V_l = 0 V$ (Devices with suffix F) , $V_l = V_{CCl}^{(2)}$ (Devices without suffix F)		1.2	1.7	
I _{CC1} , I _{CC2}	Supply current	DC Signal	DC signal: $V_I = V_{CCI}^{(2)}$ (Devices with suffix F) , $V_I = 0$ V(Devices without suffix F)		2.4	3.4	mA
I _{CC1} , I _{CC2}		1 Mbps			1.8	2.6	
I _{CC1} , I _{CC2}		10 Mbps	AC Signal: All channels switching with square wave clock input; C ₁ = 15 pF		2.1	2.8	
I _{CC1} , I _{CC2}		100 Mbps			4.9	5.9	



6.9 Switching Characteristics, 5 V

 $V_{CC1} = V_{CC2} = 5 \text{ V} \pm 10\%$ (over recommended operating conditions unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
t _{PLH} , t _{PHL}	Propagation delay time	See Figure 7	6	10.7	16	20	
PWD ⁽¹⁾	Pulse width distortion t _{PHL} - t _{PLH}	See Figure 7		0.6	4.6	ns	
t _{sk(pp)} ⁽²⁾	Part-to-part skew time				4.5	ns	
t _r	Output signal rise time	See Figure 7		2.4	3.9	20	
t _f	Output signal fall time			2.4	3.9	ns	
t _{fs}	Default output delay time from input power loss	Measured from the time V_{CC} goes below 1.7 V. See Figure 8		0.2	9	μs	
t _{ie}	Time interval error	2 ¹⁶ - 1 PRBS data at 100 Mbps		1		ns	

(1) Also known as Pulse Skew.

(2) t_{sk(pp)} is the magnitude of the difference in propagation delay times between any terminals of different devices switching in the same direction while operating at identical supply voltages, temperature, input signals and loads.

6.10 Switching Characteristics, 3.3 V

 $V_{CC1} = V_{CC2} = 3.3 \text{ V} \pm 10\%$ (over recommended operating conditions unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t _{PLH} , t _{PHL}	Propagation delay time	See Figure 7	6	10.8	16	2
PWD ⁽¹⁾	Pulse width distortion t _{PHL} - t _{PLH}	See Figure 7		0.7	4.7	ns
t _{sk(pp)} ⁽²⁾	Part-to-part skew time				4.5	
t _r	Output signal rise time	See Figure 7		1.3	3	ns
t _f	Output signal fall time			1.3	3	
t _{fs}	Default output delay time from input power loss	Measured from the time V_{CC} goes below 1.7 V. See Figure 8 $$		0.2	9	μs
t _{ie}	Time interval error	2 ¹⁶ - 1 PRBS data at 100 Mbps		1		ns

(1) Also known as Pulse Skew.

(2) t_{sk(pp)} is the magnitude of the difference in propagation delay times between any terminals of different devices switching in the same direction while operating at identical supply voltages, temperature, input signals and loads.

6.11 Switching Characteristics, 2.5 V

 $V_{CC1} = V_{CC2} = 2.5 \text{ V} \pm 10\%$ (over recommended operating conditions unless otherwise noted)

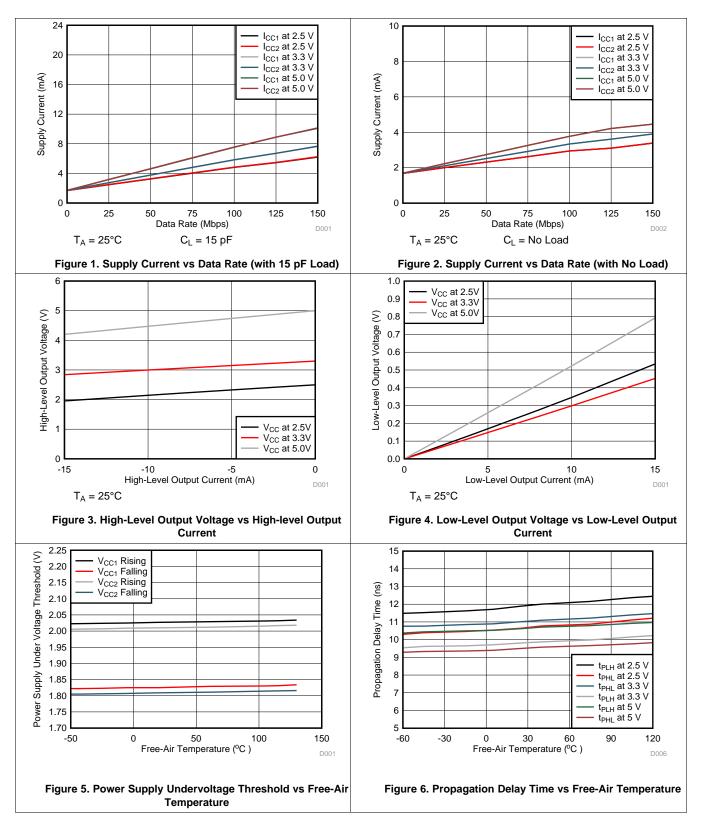
	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t _{PLH} , t _{PHL}	Propagation delay time	See Figure 7	7.5	11.7	17.5	
PWD ⁽¹⁾	Pulse width distortion t _{PHL} - t _{PLH}	See Figure 7		0.7	4.7	ns
t _{sk(pp)} ⁽²⁾	Part-to-part skew time				4.5	
t _r	Output signal rise time	Octo Finanza Z		1.8	3.5	ns
t _f	Output signal fall time	See Figure 7		1.8	3.5	
t _{fs}	Default output delay time from input power loss	Measured from the time V_{CC} goes below 1.7 V. See Figure 8		0.2	9	μs
t _{ie}	Time interval error	2 ¹⁶ - 1 PRBS data at 100 Mbps		1		ns

(1) Also known as Pulse Skew.

t_{sk(pp)} is the magnitude of the difference in propagation delay times between any terminals of different devices switching in the same direction while operating at identical supply voltages, temperature, input signals and loads.

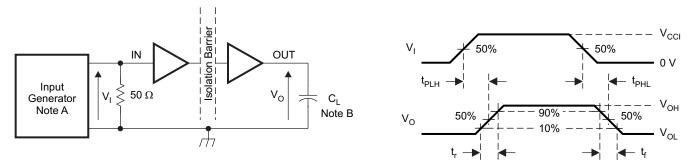


6.12 Typical Characteristics



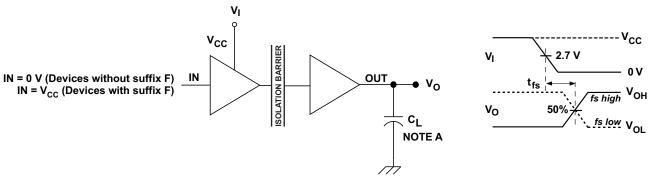


7 Parameter Measurement Information



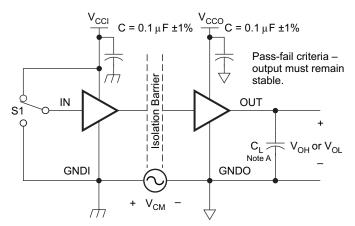
- A. The input pulse is supplied by a generator having the following characteristics: PRR \leq 50 kHz, 50% duty cycle, t_r \leq 3 ns, t_f \leq 3ns, Z_O = 50 Ω . At the input, 50 Ω resistor is required to terminate Input Generator signal. It is not needed in actual application.
- B. $C_L = 15 \text{ pF}$ and includes instrumentation and fixture capacitance within ±20%.

Figure 7. Switching Characteristics Test Circuit and Voltage Waveforms



A. $C_L = 15 \text{ pF}$ and includes instrumentation and fixture capacitance within ±20%.

Figure 8. Default Output Delay Time Test Circuit and Voltage Waveforms



A. $C_L = 15 \text{ pF}$ and includes instrumentation and fixture capacitance within ±20%.

Figure 9. Common-Mode Transient Immunity Test Circuit



8 Detailed Description

8.1 Overview

ISO7821 employs an ON-OFF Keying (OOK) modulation scheme to transmit the digital data across a silicon dioxide based isolation barrier. The transmitter sends a high frequency carrier across the barrier to represent one digital state and sends no signal to represent the other digital state. The receiver demodulates the signal after advanced signal conditioning and produces the output through a buffer stage. These devices also incorporates advanced circuit techniques to maximize the CMTI performance and minimize the radiated emissions due the high frequency carrier and IO buffer switching. The conceptual block diagram of a digital capacitive isolator, Figure 10, shows a functional block diagram of a typical channel.

8.2 Functional Block Diagram

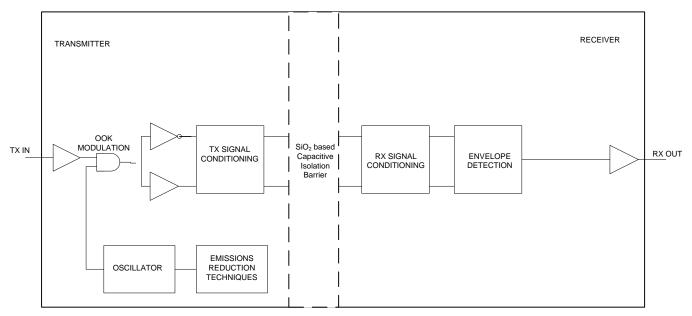


Figure 10. Conceptual Block Diagram of a Digital Capacitive Isolator

Also a conceptual detail of how the ON/OFF Keying scheme works is shown in Figure 11.

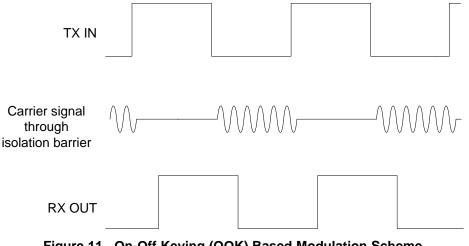


Figure 11. On-Off Keying (OOK) Based Modulation Scheme



8.3 Feature Description

ISO7821 is available in two channel configurations and default output state options to enable a variety of application uses.

PRODUCT	CHANNEL DIRECTION	RATED ISOLATION	MAX DATA RATE	DEFAULT OUTPUT
ISO7821	1 Forward, 1 Reverse	5700 V_{RMS} / 8000 V_{PK} $^{(1)}$	100 Mbps	High
ISO7821F	1 Forward, 1 Reverse	5700 V_{RMS} / 8000 V_{PK} $^{(1)}$	100 Mbps	Low

(1) See the *Regulatory Information* section for detailed isolation ratings.

8.3.1 High Voltage Feature Description

8.3.1.1 Package Insulation and Safety-Related Specifications

over recommended operating conditions (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
L(I01)	Minimum air gap (clearance)	Shortest terminal-to-terminal distance through air	DW-16	8			mm
L(I02) ⁽¹⁾	Minimum external tracking (creepage)	Shortest terminal-to-terminal distance across the package surface	DW-16	8			mm
CTI	Tracking resistance (comparative tracking index)	DIN EN 60112 (VDE 0303-11); IEC 60112; UL 746A		600			V
D	lociation registered input to output(2)	V _{IO} = 500 V, T _A = 25°C		10 ¹²			Ω
R _{IO}	Isolation resistance, input to output ⁽²⁾	$V_{IO} = 500 \text{ V}, 100^{\circ}\text{C} \le \text{T}_{\text{A}} \le \text{max}$		10 ¹¹			Ω
C _{IO}	Barrier capacitance, input to output ⁽²⁾	$V_{IO} = 0.4 \text{ x} \sin (2\pi ft), f = 1 \text{ MHz}$			2		рF
CI	Input capacitance ⁽³⁾	$V_I = V_{CC}/2 + 0.4 \text{ x} \sin (2\pi ft), f = 1 \text{ MHz}, V_{CC} = 5 \text{ V}$			2		pF

(1) Per JEDEC package dimensions.

(2) All pins on each side of the barrier tied together creating a two-terminal device.

(3) Measured from input pin to ground.

NOTE

Creepage and clearance requirements should be applied according to the specific equipment isolation standards of an application. Care should be taken to maintain the creepage and clearance distance of a board design to ensure that the mounting pads of the isolator on the printed-circuit board do not reduce this distance.

Creepage and clearance on a printed-circuit board become equal in certain cases. Techniques such as inserting grooves and/or ribs on a printed circuit board are used to help increase these specifications.



8.3.1.2 Insulation Characteristics

	PARAMETER ⁽¹⁾	TEST CONDITIONS	SPECIFICATION	UNIT	
DTI	Distance through the insulation	Minimum internal gap (internal clearance)	21	μm	
V	Moving un inclution working voltage	Time dependent dielectrie breekdeuur (TDDD) test	1500	V _{RMS}	
V _{IOWM}	Maximum isolation working voltage	Time dependent dielectric breakdown (TDDB) test	2121	V _{DC}	
DIN V V	DE V 0884-10 (VDE V 0884-10):2006-12				
V _{IOTM}	Maximum transient isolation voltage	V _{TEST} = V _{IOTM} t = 60 sec (qualification) t= 1 sec (100% production)	8000	V _{PK}	
V _{IOSM}	Maximum surge isolation voltage	Test method per IEC 60065, 1.2/50 μs waveform, V_{TEST} = 1.6 x V_{IOSM} = 12800 V_{PK} (qualification)	8000	V _{PK}	
VIORM	Maximum repetitive peak isolation voltage		2121	V _{PK}	
		Method a, After Input/Output safety test subgroup 2/3, $V_{PR} = V_{IORM} \times 1.2$, t = 10 s, Partial discharge < 5 pC	2545		
V _{PR}	Input-to-output test voltage	Method a, After environmental tests subgroup 1, $V_{PR} = V_{IORM} \times 1.6$, t = 10 s, Partial Discharge < 5 pC	3394	V _{PK}	
		Method b1,After environmental tests subgroup 1, $V_{PR} = V_{IORM} \times 1.875$, t = 1 s (100% Production test) Partial discharge < 5 pC	3977		
R _S	Isolation resistance	$V_{IO} = 500 \text{ V at } T_{S}$	>10 ⁹	Ω	
	Pollution degree		2		
UL 1577		·		•	
V _{ISO}	Withstanding isolation voltage	V_{TEST} = V_{ISO} = 5700 $V_{RMS},$ t = 60 sec (qualification); V_{TEST} = 1.2 x V_{ISO} = 6840 V_{RMS} , t = 1 sec (100% production)	5700	V _{RMS}	

(1) Climatic Classification 55/125/21

8.3.1.3 IEC 60664-1 Ratings Table

PARA	METER	TEST CONDITIONS	SPECIFICATION
Basic isolation group		Material group	I
Installation algoritization		Rated mains voltage ≤ 600 V _{RMS}	I–IV
Installation classification	DW package	Rated mains voltage ≤ 1000 V _{RMS}	I–III



8.3.1.4 Regulatory Information

DW package certifications are complete.

VDE	CSA	UL	CQC
Certified according to DIN V VDE V 0884-10 (VDE V 0884- 10):2006-12 and DIN EN 60950- 1 (VDE 0805 Teil 1):2011-01	Approved under CSA Component Acceptance Notice 5A, IEC 60950-1, IEC 61010-1, and IEC 60601-1	Recognized under UL 1577 Component Recognition Program	Certified according to GB 4943.1- 2011
Reinforced insulation Maximum transient isolation voltage, 8000 V _{PK} ; Maximum repetitive peak isolation voltage, 2121 V _{PK} ; Maximum surge isolation voltage, 8000 V _{PK}	$\begin{array}{c} \mbox{Reinforced insulation per CSA} \\ \mbox{61010-1-12 and IEC 61010-1} \\ \mbox{3rd Ed., 300 V_{RMS} max working} \\ \mbox{voltage;} \\ \mbox{Reinforced insulation per CSA} \\ \mbox{60950-1-07+A1+A2 and IEC} \\ \mbox{60950-1-1} \\ \mbox{60001-1} \\ \mbox{1.14 and IEC} \\ \mbox{60601-1} \\ \mbox{1.14 and IEC} \\ 1.14 a$	Single protection, 5700 V _{RMS} ⁽¹⁾	Reinforced Insulation, Altitude ≤ 5000 m, Tropical Climate, 250 V _{RMS} maximum working voltage
Certificate number: 40040142	Master contract number: 220991	File number: E181974	Certificate number: CQC15001121716

(1) Production tested \ge 6840 V_{RMS} for 1 second in accordance with UL 1577.

ISO7821, ISO7821F

SLLSEM2D - NOVEMBER 2014 - REVISED JULY 2015

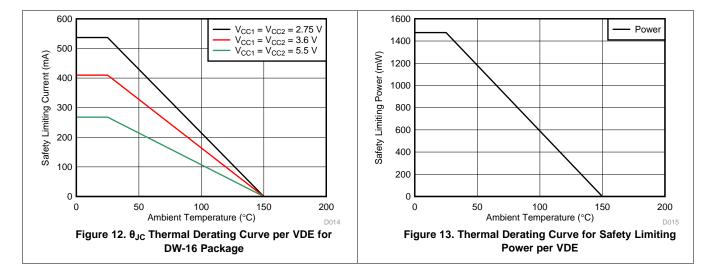


8.3.1.5 Safety Limiting Values

Safety limiting intends to prevent potential damage to the isolation barrier upon failure of input or output circuitry. A failure of the I/O can allow low resistance to ground or the supply and, without current limiting, dissipate sufficient power to overheat the die and damage the isolation barrier potentially leading to secondary system failures.

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
		$R_{\theta JA} = 84.7^{\circ}C/W, V_I = 5.5 V, T_J = 150^{\circ}C, T_A = 25^{\circ}C$			268		
I _S (DW-16)	I _S (DW-16) Safety input, output, or supply current for DW-16 package	$R_{\theta JA} = 84.7^{\circ}C/W, V_I = 3.6 V, T_J = 150^{\circ}C, T_A = 25^{\circ}C$			410	mA	
		$R_{\theta JA} = 84.7^{\circ}C/W, V_I = 2.75 V, T_J = 150^{\circ}C, T_A = 25^{\circ}C$			537		
P _S	Safety input, output, or total power	$R_{\theta JA} = 84.7^{\circ}C/W, T_{J} = 150^{\circ}C, T_{A} = 25^{\circ}C$			1476	mW	
T _S	Maximum case temperature				150	°C	

The maximum safety temperature is the maximum junction temperature specified for the device. The power dissipation and junction-to-air thermal impedance of the device installed in the application hardware determines the junction temperature. The assumed junction-to-air thermal resistance in the Thermal Informationis that of a device installed on a High-K test board for Leaded Surface Mount Packages. The power is the recommended maximum input voltage times the current. The junction temperature is then the ambient temperature plus the power times the junction-to-air thermal resistance.





8.4 Device Functional Modes

ISO7821DW functional modes are shown in Table 1.

V _{CCI}	V _{cco}	INPUT (INx) ⁽²⁾	OUTPUT (OUTx)	COMMENTS
		Н	Н	Normal Operation:
PU	PU	L	L	A channel output assumes the logic state of its input.
10		Open	Default	Default mode: When INx is open, the corresponding channel output goes to its default high logic state. Default= High for ISO7821 and Low for ISO7821F.
PD	PU	x	Default	Default mode: When V_{CCI} is unpowered, a channel output assumes the logic state based on the selected default option.Default= High for ISO7821 and Low for ISO7821F. When V_{CCI} transitions from unpowered to powered-up, a channel output assumes the logic state of its input. When V_{CCI} transitions from powered-up to unpowered, channel output assumes the selected default state.
Х	PD	х	Undetermined	When V_{CCO} is unpowered, a channel output is undetermined $^{(3)}$. When V_{CCO} transitions from unpowered to powered-up, a channel output assumes the logic state of its input

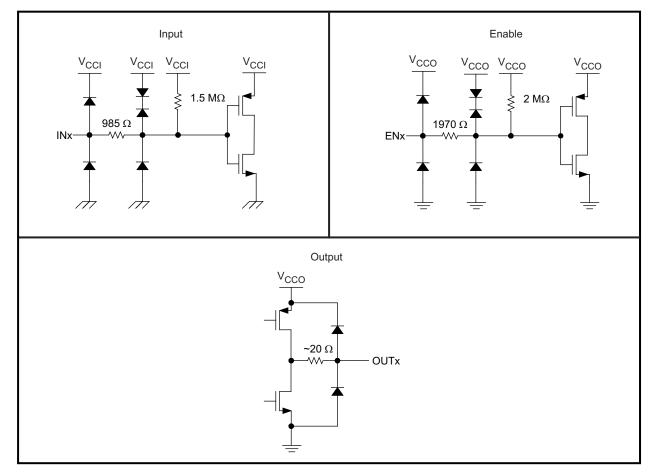
Table 1. ISO7821DW Function Table⁽¹⁾

 V_{CCI} = Input-side V_{CC} ; V_{CCO} = Output-side V_{CC} ; PU = Powered up ($V_{CC} \ge 2.25$ V); PD = Powered down ($V_{CC} \le 1.7$ V); X = Irrelevant; H = High level; L = Low level (1)

A strongly driven input signal can weakly power the floating V_{CC} via an internal protection diode and cause undetermined output. The outputs are in undetermined state when 1.7 V < V_{CCI}, V_{CCO} < 2.25 V. (2)

(3)

8.4.1 Device I/O Schematics





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9 Applications and Implementation

NOTE

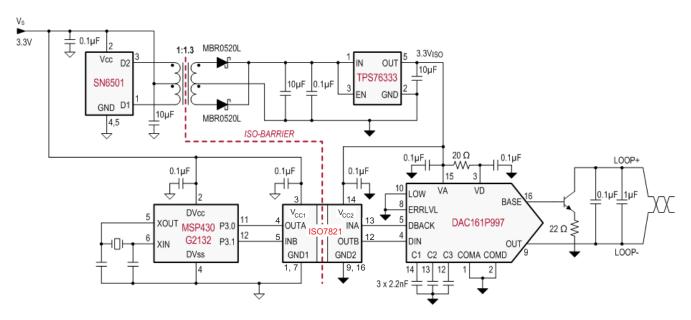
Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

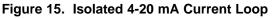
9.1 Application Information

The ISO7821 is a high-performance, dual-channel digital isolator with 5.7 kV_{RMS} isolation voltage. It utilizes single-ended CMOS-logic switching technology. Its supply voltage range is from 2.25 V to 5.5 V for both supplies, V_{CC1} and V_{CC2}. When designing with digital isolators, it is important to keep in mind that due to the single-ended design structure, digital isolators do not conform to any specific interface standard and are only intended for isolating single-ended CMOS or TTL digital signal lines. The isolator is typically placed between the data controller (that is, μ C or UART), and a data converter or a line transceiver, regardless of the interface type or standard.

9.2 Typical Application

ISO7821DW can be used with Texas Instruments' mixed signal micro-controller, digital-to-analog converter, transformer driver, and voltage regulator to create an isolated 4-20 mA current loop.





9.2.1 Design Requirements

For the ISO7821, use the parameters shown in Table 2.

 Table 2. Design Parameters

PARAMETER	VALUE
Supply voltage	2.25 V to 5.5 V
Decoupling capacitor between V_{CC1} and GND1	0.1 µF
Decoupling capacitor from V _{CC2} and GND2	0.1 µF



9.2.2 Detailed Design Procedure

Unlike optocouplers, which need external components to improve performance, provide bias, or limit current, ISO7821 only needs two external bypass capacitors to operate.

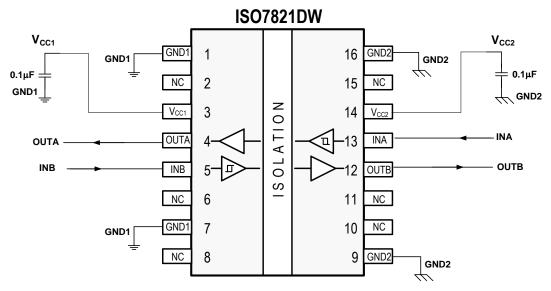


Figure 16. Typical ISO7821DW Circuit Hook-up

9.2.2.1 Electromagnetic Compatibility (EMC) Considerations

Many applications in harsh industrial environment are sensitive to disturbances such as electrostatic discharge (ESD), electrical fast transient (EFT), surge and electromagnetic emissions. These electromagnetic disturbances are regulated by international standards such as IEC 61000-4-x and CISPR 22. Although system-level performance and reliability depends, to a large extent, on the application board design and layout, the ISO7821 incorporate many chip-level design improvements for overall system robustness. Some of these improvements include:

- Robust ESD protection for input and output signal pins and inter-chip bond pads.
- Low-resistance connectivity of ESD cells to supply and ground pins.
- Enhanced performance of high voltage isolation capacitor for better tolerance of ESD, EFT and surge events.
- Bigger on-chip decoupling capacitors to bypass undesirable high energy signals through a low impedance path.
- PMOS and NMOS devices isolated from each other by using guard rings to avoid triggering of parasitic SCRs.
- Reduced common mode currents across the isolation barrier by ensuring purely differential internal operation.

9.2.3 Application Performance Curve

Typical eye diagram of ISO7821 indicate low jitter and wide open eye at the maximum data rate of 100 Mbps.

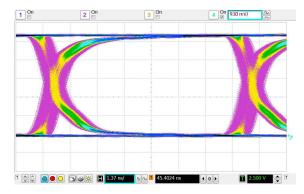


Figure 17. Eye Diagram at 100 Mbps PRBS, 5 V and 25°C

10 Power Supply Recommendations

To ensure reliable operation at all data rates and supply voltages, a 0.1 μ F bypass capacitor is recommended at input and output supply pins (V_{CC1} and V_{CC2}). The capacitors should be placed as close to the supply pins as possible. If only a single primary-side power supply is available in an application, isolated power can be generated for the secondary-side with the help of a transformer driver such as Texas Instruments' SN6501. For such applications, detailed power supply design and transformer selection recommendations are available in SN6501 datasheet (SLLSEA0).



11 Layout

11.1 PCB Material

For digital circuit boards operating below 150 Mbps, (or rise and fall times higher than 1 ns), and trace lengths of up to 10 inches, use standard FR-4 epoxy-glass as PCB material. FR-4 (Flame Retardant 4) meets the requirements of Underwriters Laboratories UL94-V0, and is preferred over cheaper alternatives due to its lower dielectric losses at high frequencies, less moisture absorption, greater strength and stiffness, and its self-extinguishing flammability-characteristics.

11.2 Layout Guidelines

A minimum of four layers is required to accomplish a low EMI PCB design (see Figure 18). Layer stacking should be in the following order (top-to-bottom): high-speed signal layer, ground plane, power plane and low-frequency signal layer.

- Routing the high-speed traces on the top layer avoids the use of vias (and the introduction of their inductances) and allows for clean interconnects between the isolator and the transmitter and receiver circuits of the data link.
- Placing a solid ground plane next to the high-speed signal layer establishes controlled impedance for transmission line interconnects and provides an excellent low-inductance path for the return current flow.
- Placing the power plane next to the ground plane creates additional high-frequency bypass capacitance of approximately 100 pF/in².
- Routing the slower speed control signals on the bottom layer allows for greater flexibility as these signal links usually have margin to tolerate discontinuities such as vias.

If an additional supply voltage plane or signal layer is needed, add a second power / ground plane system to the stack to keep it symmetrical. This makes the stack mechanically stable and prevents it from warping. Also the power and ground plane of each power system can be placed closer together, thus increasing the high-frequency bypass capacitance significantly.

For detailed layout recommendations, see Application Note SLLA284, Digital Isolator Design Guide.

11.3 Layout Example

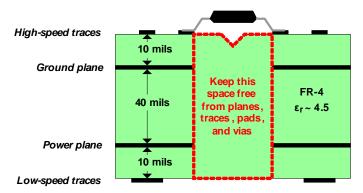


Figure 18. Layout Example



12 Device and Documentation Support

12.1 Documentation Support

12.1.1 Related Documentation

See the Isolation Glossary (SLLA353)

12.2 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

Table 3. Related Links

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY					
ISO7821	Click here	Click here	Click here	Click here	Click here					
ISO7821F	Click here	Click here	Click here	Click here	Click here					

12.3 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

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Design Support TI's Design Support Quickly find helpful E2E forums along with design support tools and contact information for technical support.

12.4 Trademarks

E2E is a trademark of Texas Instruments.

12.5 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

12.6 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical packaging and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
ISO7821DW	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-55 to 125	ISO7821	Samples
ISO7821DWR	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-55 to 125	ISO7821	Samples
ISO7821DWW	PREVIEW	SOIC	DWW	16	45	Green (RoHS & no Sb/Br)	Call TI	Level-2-260C-1 YEAR	-55 to 125	XISO7821	
ISO7821FDW	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-55 to 125	ISO7821F	Samples
ISO7821FDWR	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-55 to 125	ISO7821F	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.



PACKAGE OPTION ADDENDUM

20-Aug-2015

⁽⁶⁾ Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*Al	dimensions are nominal												
	Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
	ISO7821DWR	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1
	ISO7821FDWR	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1

TEXAS INSTRUMENTS

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PACKAGE MATERIALS INFORMATION

11-Jul-2015



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
ISO7821DWR	SOIC	DW	16	2000	367.0	367.0	38.0
ISO7821FDWR	SOIC	DW	16	2000	367.0	367.0	38.0

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